

IAP20 Rac'd PCT/770 11 JAN 2006

JBH:clm 01/11/06 6395-64819-03 473379 I-010-03

PATENT EXPRESS MAIL LABEL NO. EV629077081US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Kardous

Application No. Not yet assigned

Filed: Herewith

Confirmation No. Not yet assigned

For: SYSTEM FOR MONITORING

EXPOSURE TO IMPULSE NOISE

Examiner: Not yet assigned Art Unit: Not yet assigned

Attorney Reference No. 6395-64819-03

COMMISSIONER FOR PATENTS P.O. BOX 1450 ALEXANDRIA, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT PURSUANT TO 37 C.F.R. § 1.97(b)(1)

Listed on the accompanying form PTO-1449 and enclosed herewith are several English-language documents. Applicant respectfully requests that these documents be listed as references cited on the issued patent.

Copies of United States patents and United States published patent applications do not have to be provided to the Patent Office (37 C.F.R. 1.98(a)(2)(ii)). Copies of unpublished U.S. applications do not have to be provided, as long as the application is available on PAIR, as this requirement of 37 C.F.R. § 1.98(a)(2)(iii) has been waived by the United States Patent and Trademark Office pursuant to the Official Gazette Notice on October 19, 2004 (1287 OG 163). Applicant will provide copies of such patents or applications upon request.

Applicant filed this Information Disclosure Statement ("IDS") within three months of the filing date of a national application. As a result, no fee should be required to file this IDS.

10/564860 IAP20 ROC'G FET/FTO 11 JAN 2006

JBH:clm 01/11/06 6395-64819-03 473379 I-010-03

PATENT EXPRESS MAIL LABEL NO. EV629077081US

However, if the Patent Office determines that a fee is required for Applicant to file this IDS, please charge any such fees, or credit overpayment, to Deposit Account No. 02-4550. A duplicate copy of this IDS is enclosed.

The filing of this IDS shall not be construed to be an admission that the information cited in the statement is, or is considered to be, prior art or otherwise material to patentability as defined in 37 C.F.R. §1.56.

Respectfully submitted,

KLARQUIST SPARKMAN, LLP

 $\mathbf{B}\mathbf{v}$

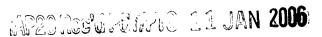
Jeffrey E. Haendler Registration No. 43,652

One World Trade Center, Suite 1600 121 S.W. Salmon Street Portland, Oregon 97204

Telephone: (503) 226-7391

Facsimile: (503) 228-9446

cc: Docketing



EXPRESS MAIL LABEL NO. EV629077081US

· INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Attorney Docket Number	6395 64819-03
	Application Number	3075 64860
	Filing Date	Not yet assigned
	First Named Inventor	Kardous
•	Art Unit	Not yet assigned
	Examiner Name	Not yet assigned

U.S. PATENT DOCUMENTS

Copies of U.S. Patent documents do not need to be provided, unless requested by the Patent and Trademark Office. For patents, provide the patent number and the issue date. For published U.S. applications, provide the publication number and the publication date. For unpublished pending patent applications, provide the application number and the filing date.

Examiner's Initials*	Cite No. (optional)	Number	Publication Date	Name of Applicant or Patentee
		3,977,257	Aug. 31,1976	Steger
- · · · · · · · - · · · · · · · · · · ·		4,003,264	Jan. 18, 1977	Erlandsson et al.
		4,028,947	Jun. 14, 1977	Cowen
		4,100,810	Jul. 18, 1978	Sima, Jr. et al.
		4,554,639	Nov. 19, 1985	Baker et al.
		4,949,580	Aug. 21, 1990	Graham et al.
		6,182,018	Jan. 30, 2001	Tran et al.
		6,350,243	Feb. 26, 2002	Johnson
		6,385,261	May 7, 2002	Tsuji et al.
		6,456,199	Sep. 24, 2002	Michael
		6,507,650	Jan. 14, 2003	Moquin
		US 2003/0191609 A1	Oct. 9, 2003	Bernardi

FOREIGN PATENT DOCUMENTS

Examiner's Initials*	Cite No. (optional)	Country	Number	Publication Date	Name of Applicant or Patentee

EXAMINER	DATE
SIGNATURE:	CONSIDERED:

^{*} Examiner: Initial if reference considered, whether or not in conformance with MPEP 609. Draw line through cite if not in conformance and not considered. Include copy of this form with next communication to applicant.

JBH:clm 01/11/06 6395-64819-03 473382 I-010-03

· INFORMATION DISCLOSURE STATEMENT BY APPLICANT

EXT RESS	MINIE ENDEE NO. E 102707700103
Attorney Docket Number	6395-64819-03
Application Number	Not yet assigned Not yet assigned
Filing Date	Not yet assigned
First Named Inventor	Kardous
Art Unit	Not yet assigned
Examiner Name	Not yet assigned

				Examiner Name	Not yet assigned	
		FO	REIGN PATENT	DOCUMENTS		
Examiner's Initials*	Cite No. (optional)	Country	Number	Publication Date	Name of Applicant or Patentee	
Examiner's Initials*	Cite No. (optional)	OTHER DOCUMENTS				
		Seiler, John P. and Giardino, Dennis A., "The Effect of Threshold on Noise Dosimeter Measurements and Interpretation of Their Results," 16 pages, August, 1994.				
		"High-Sensitivity Dynamic Pressure Sensors," sales bulletin, PCB Piezotronics, Inc., 2 pages, 2002.				
		International Search Report and Written Opinion of PCT Application No. PCT/US2004/022499				

EXAMINER	DATE
SIGNATURE:	CONSIDERED:

^{*} Examiner: Initial if reference considered, whether or not in conformance with MPEP 609. Draw line through cite if not in conformance and not considered. Include copy of this form with next communication to applicant.